

GSMDD4964

40V N-Channel MOSFETs

Product Description

These N-Channel enhancement mode power field effect transistors are using trench DMOS technology. This advance technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency fast switching applications.

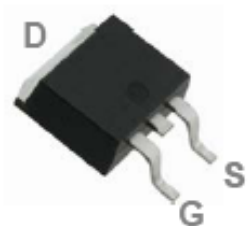
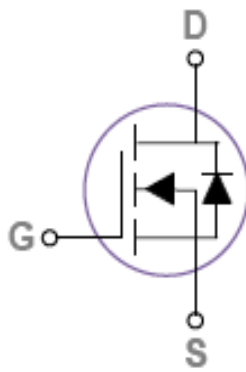
Features

- 40V, 60A, $R_{DS(ON)}=6.7m\Omega@V_{GS}=10V$
- Improved dv/dt capability
- Fast switching
- Green Device Available

Applications

- MB / VGA / Vcore
- POL Applications
- SMPS 2nd SR

Packages & Pin Assignments

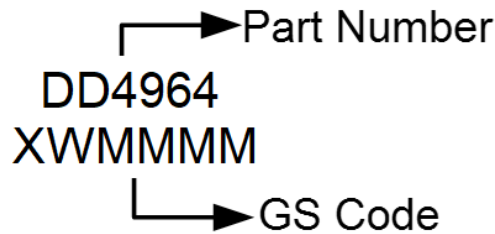
GSMDD4964DF (TO-252)	
	
Description	
Gate	
Source	
Drain	

Ordering Information



Part Number	Package	Quantity Reel
GSMDD4964DF	TO-252	2500 PCS

Marking Information



Absolute Maximum Ratings

T_c=25°C Unless otherwise noted

Symbol	Parameter	Typical	Unit
V _{DS}	Drain-Source Voltage	40	V
V _{GS}	Gate-Source Voltage	±20	V
I _D	Continuous Drain Current	T _c =25°C	60
		T _c =100°C	38
I _{DM}	Pulsed Drain Current	240	A
P _D	Power Dissipation (T _c =25°C)	62	W
	Power Dissipation (Derate above 25°C)	0.496	W/°C
T _J	Operating Junction Temperature Range	-55 to +150	°C
T _{STG}	Storage Temperature Range	-55 to +150	°C
R _{θJA}	Thermal Resistance-Junction to Ambient	62	°C/W
R _{θJC}	Thermal Resistance-Junction to Case	2.01	°C/W
EAS	Single Pulse Avalanche Energy ²	76	mJ
IAS	Single Pulse Avalanche Current ²	39	A

Electrical Characteristics

T_J=25°C Unless otherwise noted

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
Static						
V _{(BR)DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V, I _D =250uA	40	---	---	V
ΔBV _{DSS} /ΔT _J	BV _{DSS} Temperature Coefficient	Reference to 25°C, I _D =1mA	---	0.03	---	V/°C
V _{GS(th)}	Gate Threshold Voltage	V _{DS} =V _{GS} , I _D =250uA	1.2	1.6	2.5	V
ΔV _{GS(th)}	V _{GS(th)} Temperature Coefficient		---	-5	---	mV/°C
I _{GSS}	Gate-Source Leakage Current	V _{DS} =0V, V _{GS} =±20V	---	---	±100	nA
I _{DSS}	Drain-Source Leakage Current	V _{DS} =40V, V _{GS} =0V T _J =25°C	---	---	1	uA
		V _{DS} =32V, V _{GS} =0V, T _J =125°C	---	---	10	
I _S	Continuous Source Current ²	V _G =V _D =0V, Force Current	---	---	60	A
I _{SM}	Pulsed Source Current ²		---	---	120	
R _{DS(on)}	Drain-Source On-Resistance ²	V _{GS} =10V, I _D =10A	---	5.7	6.7	mΩ
		V _{GS} =4.5V, I _D =5A	---	7.0	8.8	mΩ
g _{FS}	Forward Transconductance	V _{DS} =10V, I _D =3A	---	16	---	S
V _{SD}	Diode Forward Voltage	V _{GS} =0V, I _S =1A T _J =25°C	---	---	1	V
Dynamic						
Q _g	Total Gate Charge ^{2,3}	V _{DS} =20V, V _{GS} =4.5V, I _D =10A	---	16.2	32	nC
Q _{gs}	Gate-Source Charge ^{2,3}		---	3.85	7	
Q _{gd}	Gate-Drain Charge ^{2,3}		---	6.05	12	
C _{iss}	Input Capacitance	V _{DS} =25V, V _{GS} =0V, f=1MHz	---	1540	2500	pF
C _{oss}	Output Capacitance		---	171	330	
C _{rss}	Reverse Transfer Capacitance		---	115	220	
t _{d(on)}	Turn-On Time ^{2,3}	V _{DD} =15V, I _D =1A, V _{GS} =10V, R _G =6Ω	---	13.6	25	ns
t _r			---	2.5	5	
t _{d(off)}	Turn-Off Time ^{2,3}		---	68	120	
t _f			---	5	10	
R _g	Gate Resistance	V _{DS} =0V, V _{GS} =0V, f=1MHz	---	1.2	2.2	Ω

Note:

1. Repetitive Rating: Pulsed width limited by maximum junction temperature.
2. The data tested by pulsed, pulse width ≤ 300us, duty cycle ≤ 2%.
3. Essentially independent of operating temperature.
4. V_{DD}=25V, V_{GS}=10V, L=0.1mH, I_{AS}=39A., Starting T_J=25°C

Typical Performance Characteristics

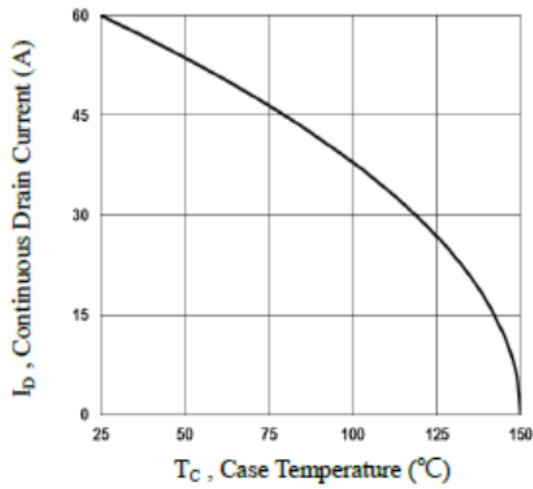


Fig.1 Continuous Drain Current vs. T_c

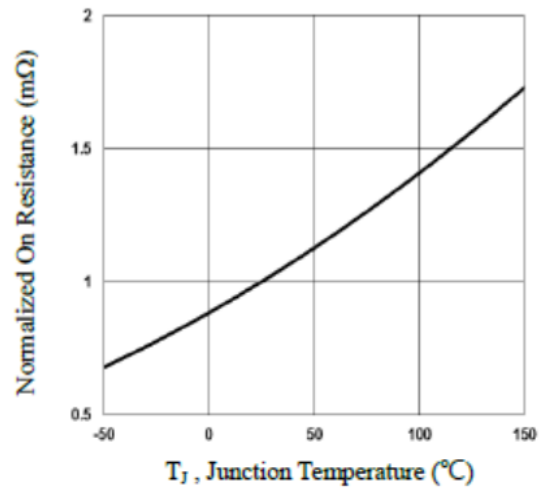


Fig.2 Normalized $R_{DS(on)}$ vs. T_j

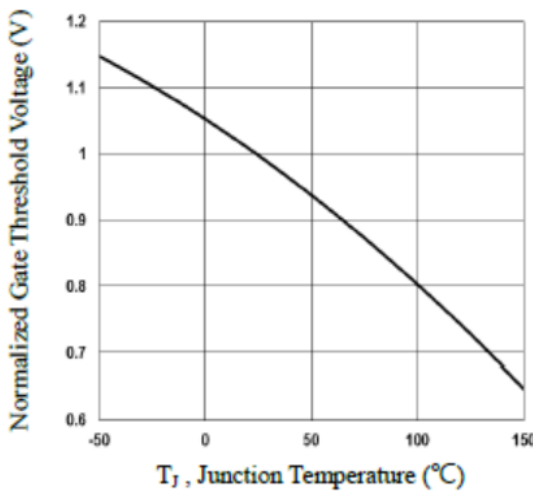


Fig.3 Normalized V_{th} vs. T_j

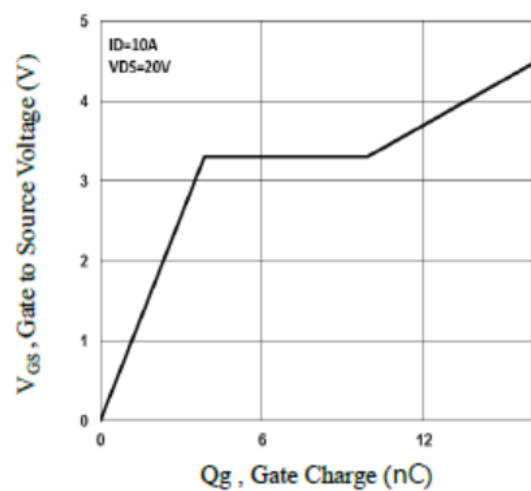


Fig.4 Gate Charge Waveform

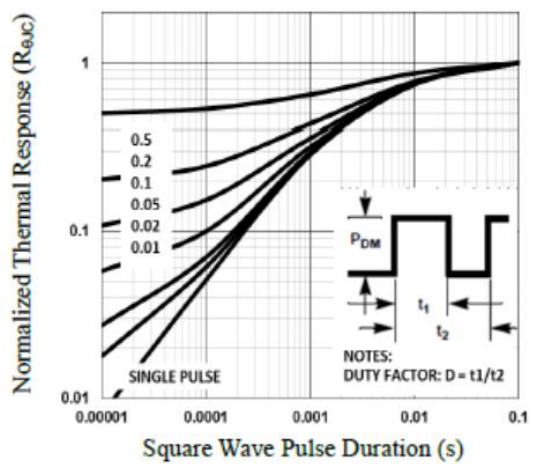


Fig.5 Normalized Transient Impedance

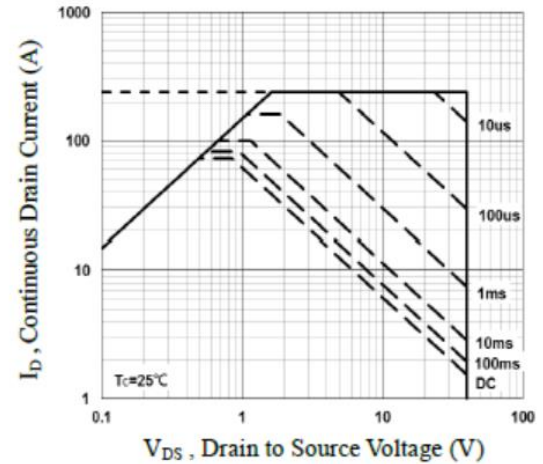


Fig.6 Maximum Safe Operation Area

Typical Performance Characteristics (Continue)

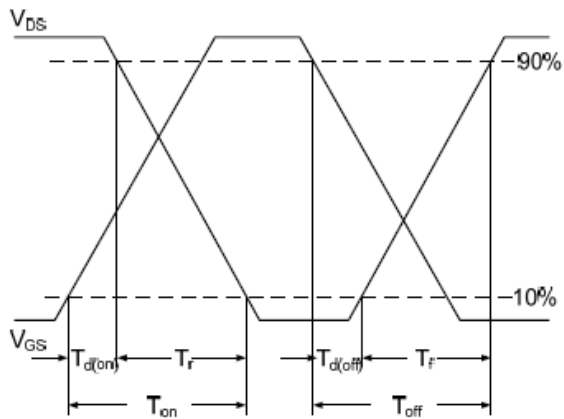


Fig.7 Switching Time Waveform

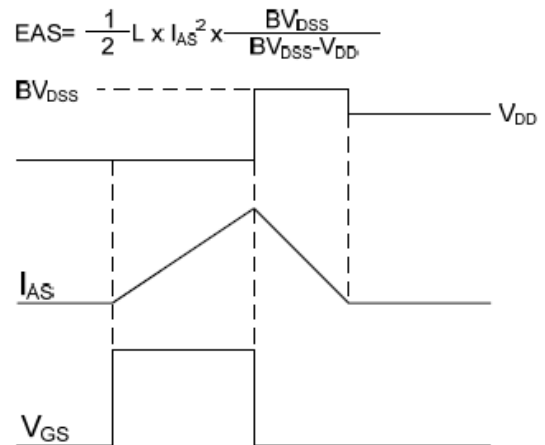
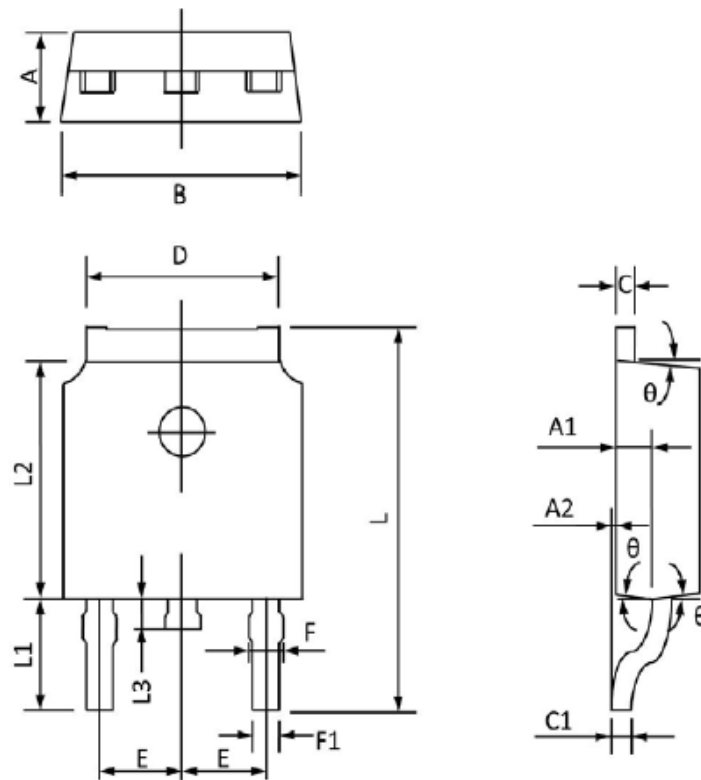


Fig.8 EAS Waveform

Package Dimension

Package Dimension

TO-252-2L









Symbol	Dimensions In Millimeters		Dimensions In Inches	
	MAX	MIN	MAX	MIN
A	2.400	2.200	0.094	0.087
A1	1.110	0.910	0.044	0.036
A2	0.150	0.000	0.006	0.000
B	6.800	6.400	0.268	0.252
C	0.580	0.450	0.023	0.018
C1	0.580	0.460	0.023	0.018
D	5.500	5.100	0.217	0.201
E	2.386	2.186	0.094	0.086
F	0.940	0.600	0.037	0.024
F1	0.860	0.500	0.034	0.020
L	10.400	9.400	0.409	0.370
L1	3.000	2.400	0.118	0.094
L2	6.200	5.400	0.244	0.213
L3	1.200	0.600	0.047	0.024
θ	9°	3°	9°	3°

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